

FCC - TEST REPORT

Report Number : 68.940.18.0010.01 Date of Issue: April 18, 2018

Model : HSD8023B, HSD8023C

Product Type : Icamp Bluetooth Speaker With Night Light

Applicant : SHENZHEN HIGHSTAR ELECTRICAL CO., LTD.

Address : 2F&4F,Building 6, Highstar Industrial zone,Gangtou
Bantian Street, Longgang District,
Shenzhen, China

Production Facility : SHENZHEN HIGHSTAR ELECTRICAL CO., LTD.

Address : 2F&4F,Building 6, Highstar Industrial zone,Gangtou
: Bantian Street, Longgang District,
: Shenzhen, China

Test Result : ☒ **Positive** ☐ **Negative**

Total pages including Appendices : 44

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2 Details about the Test Laboratory

Details about the Test Laboratory

Test Site 1

Company name: TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch
Building 12 & 13, Zhiheng Wisdomland Business Park, Nantou
Checkpoint Road 2, Nanshan District
Shenzhen 518052
P.R. China

Telephone: 86 755 8828 6998
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FCC Registration No.: 514049

3 Description of the Equipment Under Test

Product:	Icamp Bluetooth Speaker With Night Light
Model no.:	HSD8023B, HSD8023C
FCC ID:	2AAZR-HSD8023CB
Options and accessories:	Nil
Ratings:	3.7VDC (Supplied by the internal Li-ion rechargeable battery) 5.0VDC, 2.0A (Charging by USB Port); 5.0VDC, 2.4A (Discharging by USB Port)
RF Transmission Frequency:	2402MHz-2480MHz
No. of Operated Channel:	79
Modulation:	GFSK, $\pi/4$ -DQPSK
Antenna Type:	Integrated antenna
Antenna Gain:	-0.58dBi
Description of the EUT:	The Equipment Under Test (EUT) is a Icamp Bluetooth Speaker With Night Light operated at 2.4GHz

4 Summary of Test Standards

Test Standards	
FCC Part 15 Subpart C 10-1-2016 Edition	PART 15 - RADIO FREQUENCY DEVICES Subpart C - Intentional Radiators

All the test methods were according to Public Notice DA 00-705 -Frequency Hopper Spread Spectrum Test Procedure released by FCC on March 30, 2000 and ANSI C63.10-2013.

5 Summary of Test Results

Technical Requirements				
FCC Part 15 Subpart C 247				
Test Condition		Pages	Test Result	Test Site
§15.207	Conducted emission AC power port	10	Pass	Site 1
§15.247(b)(1)	Conducted peak output power	13	Pass	Site 1
§15.247(e)	Power spectral density*	--	N/A	--
§15.247(a)(2)	6dB bandwidth*	--	N/A	--
§15.247(a)(1)	20dB bandwidth and 99% Occupied Bandwidth	18	Pass	Site 1
§15.247(a)(1)	Carrier frequency separation	23	Pass	Site 1
§15.247(a)(1)(iii)	Number of hopping frequencies	26	Pass	Site 1
§15.247(a)(1)(iii)	Dwell Time	28	Pass	Site 1
§15.247(d)	Spurious RF conducted emissions	31	Pass	Site 1
§15.247(d)	Band edge	35	Pass	Site 1
§15.247(d) & §15.209 & §15.203	Spurious radiated emissions for transmitter and receiver	38	Pass	Site 1
§15.203	Antenna requirement	See note 1	Pass	--

Note 1: N/A=Not Applicable.

Note 2: The EUT uses an Integrated antenna, which gain is -0.58dBi. In accordance to §15.203, it is considered sufficiently to comply with the provisions of this section.

6 General Remarks

Remarks

This submittal(s) (test report) is intended for FCC ID: 2AAZR-HSD8023CB, complies with Section 15.207, 15.205, 15.209, 15.247 of the FCC Part 15, Subpart C.

The models HSD8023B and HSD8023C are same except the model name. So all tests were applied on HSD8023C, and HSD8023B was deemed to fulfill relevant FCC requirement without further testing

SUMMARY:

All tests according to the regulations cited on page 5 were

■ - Performed

□ - **Not** Performed

The Equipment Under Test

■ - **Fulfills** the general approval requirements.

□ - **Does not** fulfill the general approval requirements.

Sample Received Date: March 07, 2018

Testing Start Date: March 07, 2018

Testing End Date: March 19, 2018

- TÜV SÜD Certification and Testing (China) Co., Ltd. Shenzhen Branch -

Reviewed by:

Prepared by:

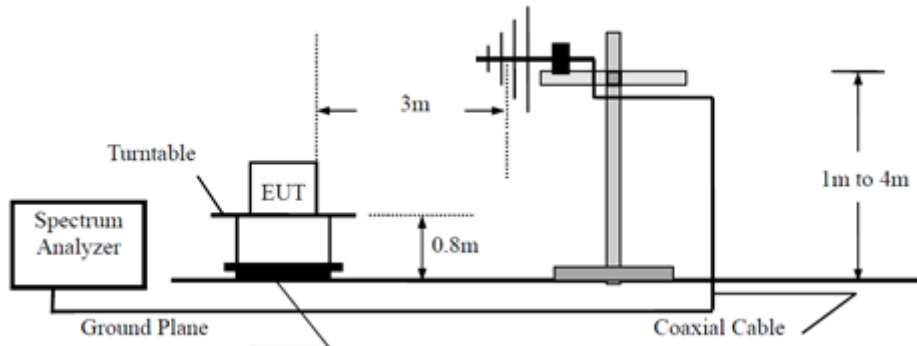


Laurent Yuan
EMC Project Manager

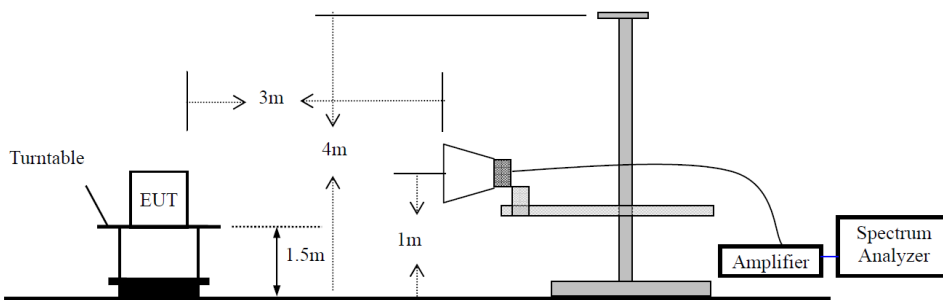
Dawi Xu
EMC Project Engineer

7 Test Setups

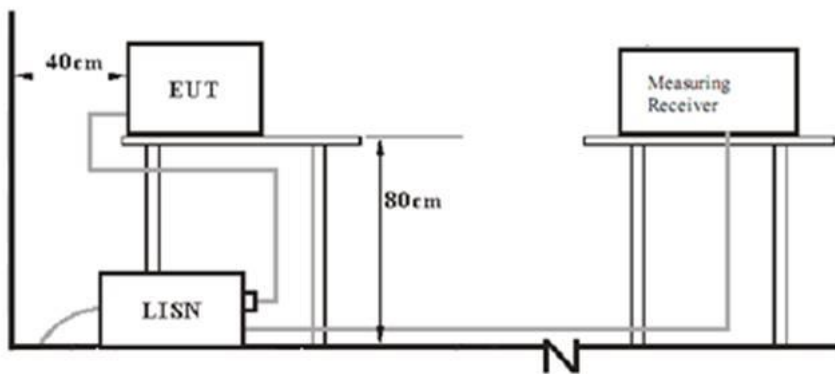
7.1 Radiated test setups Below 1GHz



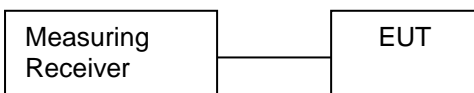
Above 1GHz



7.2 Conducted RF test setups



7.3 Conducted RF test setups



8 Systems test configuration

Auxiliary Equipment Used during Test:

DESCRIPTION	MANUFACTURER	MODEL NO.	S/N
Phone	Apple	iPhone	---
Adapter	Teka	TEKA012-052000EU	---

Test software: FCC Assist test tool, which used to control the EUT in continues transmitting mode

9 Technical Requirement

9.1 Conducted Emission

Test Method

1. The EUT was placed on a table, which is 0.8m above ground plane
2. The power line of the EUT is connected to the AC mains through a Artificial Mains Network (A.M.N.).
3. Maximum procedure was performed to ensure EUT compliance
4. A EMI test receiver is used to test the emissions from both sides of AC line

Limit

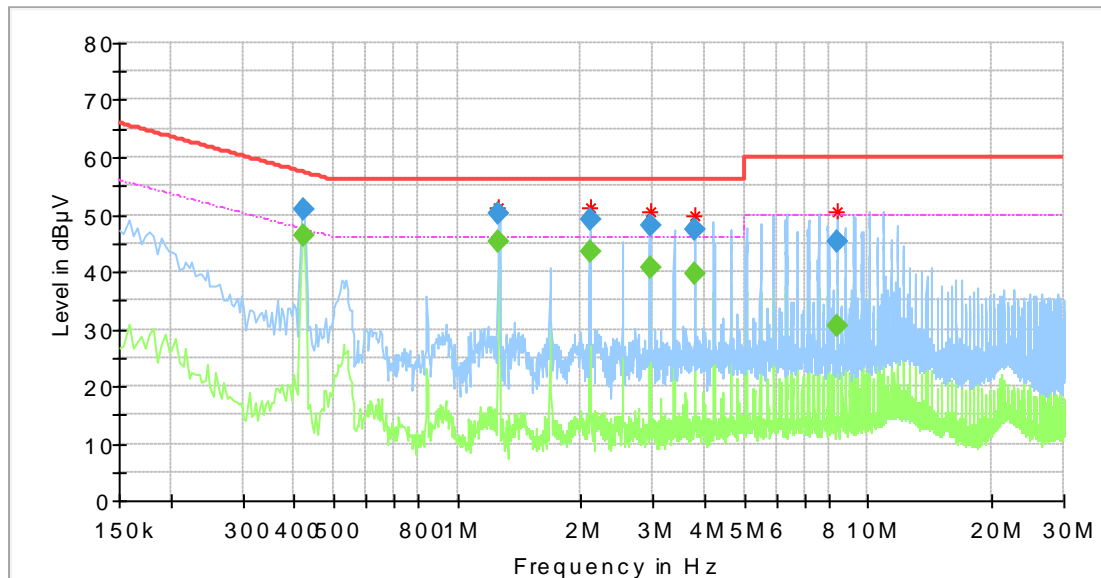
Frequency MHz	QP Limit dB μ V	AV Limit dB μ V
0.150-0.500	66-56*	56-46*
0.500-5	56	46
5-30	60	50

Remark: *Decreasing linea

Conducted Emission Test 150kHz – 30MHz

M/N: HSD8023C
 Op Cond.: Charging & ON(LAMP) & Bluetooth Transmitting
 Test Spec.: Power Line, Live
 Comment: DC 5V, 2A supplied by adapter: AC 120V/60Hz

Temperature (°C): 22.5 Relative Humidity (%): 46.7 Atmospheric Pressure(mbar) : 1012



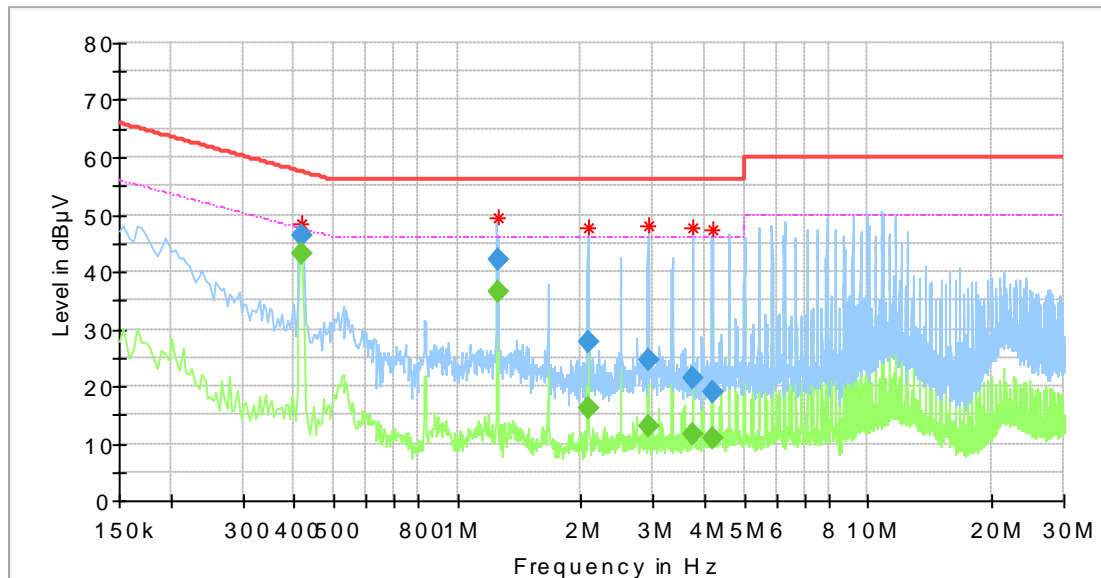
Frequency (MHz)	QuasiPeak (dBμV)	Average (dBμV)	Limit (dBμV)	Margin (dB)	Line	Corr. (dB)
0.421500	---	46.26	47.42	1.16	L1	11.4
0.421500	50.80	---	57.42	6.62	L1	11.4
1.261500	---	45.13	46.00	0.87	L1	10.2
1.261500	50.16	---	56.00	5.84	L1	10.2
2.106500	---	43.53	46.00	2.47	L1	10.3
2.106500	49.22	---	56.00	6.78	L1	10.3
2.949500	---	40.77	46.00	5.23	L1	10.3
2.949500	47.93	---	56.00	8.07	L1	10.3
3.790500	---	39.66	46.00	6.34	L1	10.3
3.790500	47.35	---	56.00	8.65	L1	10.3
8.426500	---	30.70	50.00	19.30	L1	10.5
8.426500	45.37	---	60.00	14.63	L1	10.5

Remark : “*” Correct factor=cable loss + LISN factor

Conducted Emission Test 150kHz – 30MHz

M/N: HSD8023C
 Op Cond.: Charging & ON(LAMP) & Bluetooth Transmitting
 Test Spec.: Power Line, Neutral
 Comment: DC 5V, 2A supplied by adapter: AC 120V/60Hz

Temperature (°C): 22.5 Relative Humidity (%): 46.7 Atmospheric Pressure(mbar) : 1012



Frequency (MHz)	QuasiPeak (dBμV)	Average (dBμV)	Limit (dBμV)	Margin (dB)	Line	Corr. (dB)
0.417500	---	43.32	47.50	4.18	N	10.3
0.417500	46.42	---	57.50	11.08	N	10.3
1.250500	---	36.43	46.00	9.57	N	10.4
1.250500	42.19	---	56.00	13.81	N	10.4
2.082500	---	16.18	46.00	29.82	N	10.4
2.082500	27.82	---	56.00	28.18	N	10.4
2.918500	---	12.92	46.00	33.08	N	10.5
2.918500	24.51	---	56.00	31.49	N	10.5
3.754500	---	11.44	46.00	34.56	N	10.5
3.754500	21.50	---	56.00	34.50	N	10.5
4.174500	---	11.00	46.00	35.00	N	10.5
4.174500	18.95	---	56.00	37.05	N	10.5

Remark : “*” Correct factor=cable loss + LISN factor

9.2 Conducted peak output power

Test Method

1. Use the following spectrum analyzer settings:
Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel
RBW > the 20 dB bandwidth of the emission being measured, VBW \geq RBW,
Sweep = auto, Detector function = peak, Trace = max hold
2. Add a correction factor to the display.
3. Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission. The indicated level is the peak output power

Limits

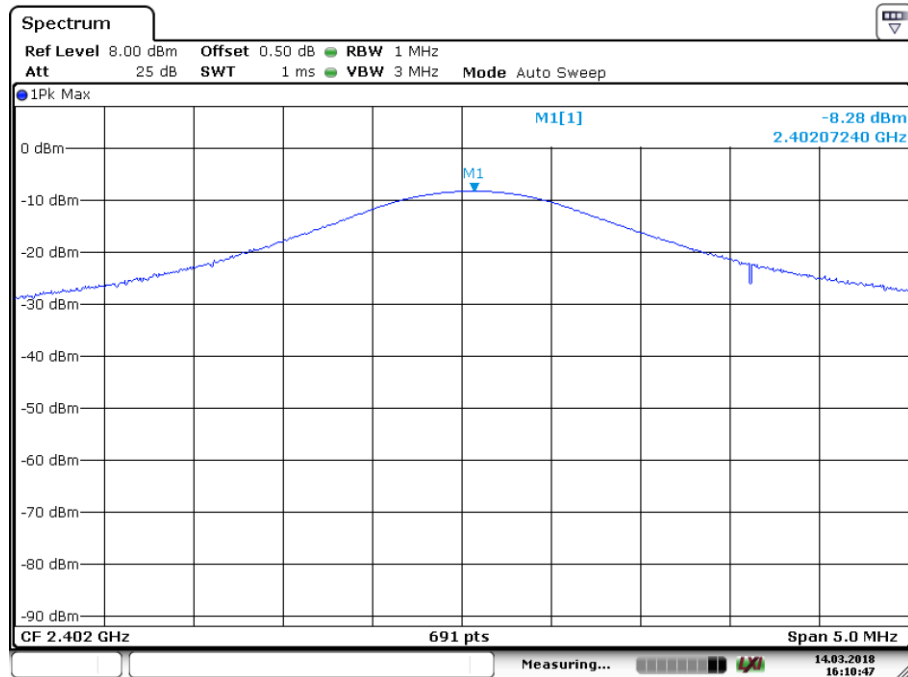
Frequency Range MHz	Limit W	Limit dBm
2400-2483.5	≤ 1	≤ 30

Conducted peak output power

Bluetooth Mode GFSK modulation Test Result

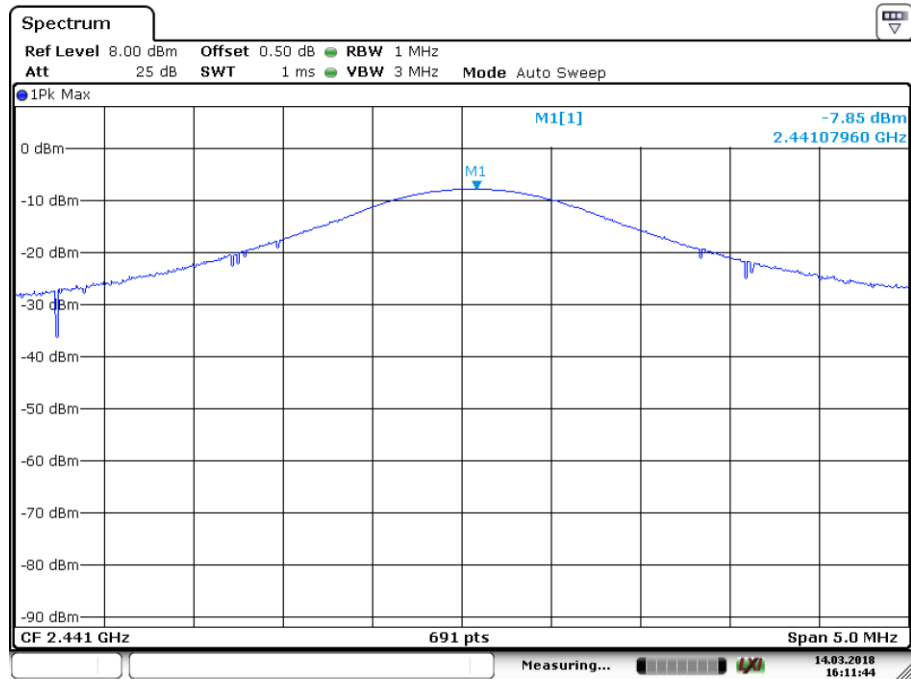
Frequency MHz	Conducted Peak Output Power dBm	Result
Low channel 2402MHz	-8.28	Pass
Middle channel 2441MHz	-7.85	Pass
High channel 2480MHz	-8.72	Pass

Low channel 2402MHz



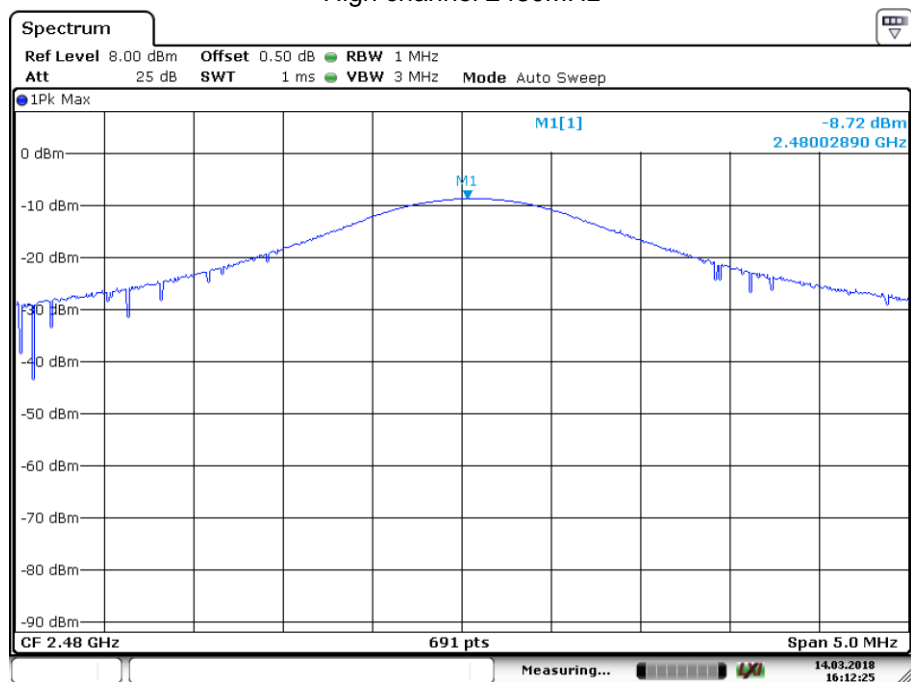
Date: 14.MAR.2018 16:10:47

Middle channel 2441MHz



Date: 14.MAR.2018 16:11:44

High channel 2480MHz

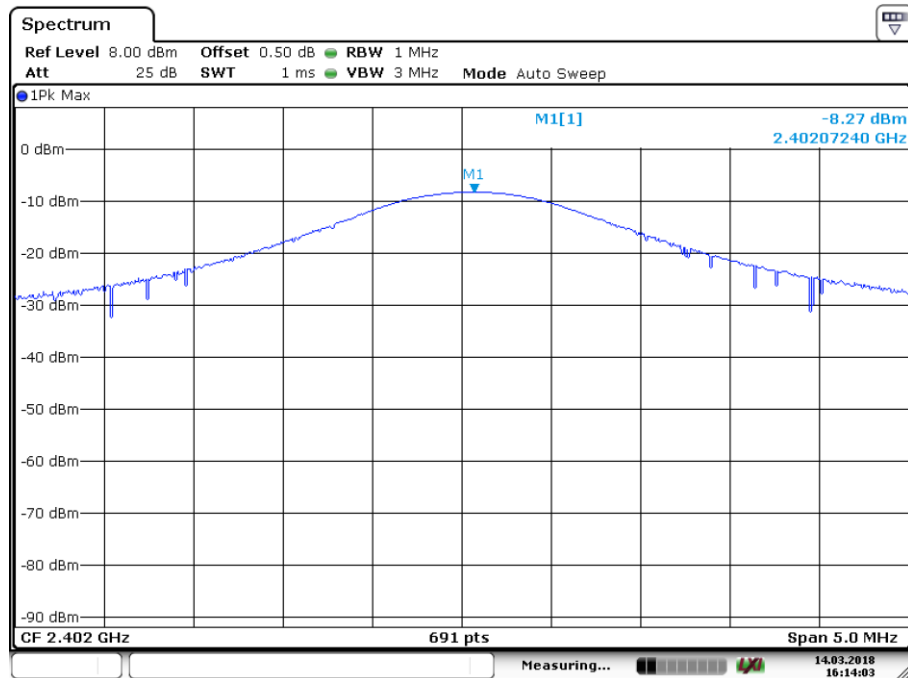


Date: 14.MAR.2018 16:12:26

Bluetooth Mode $\pi/4$ -DQPSK modulation Test Result

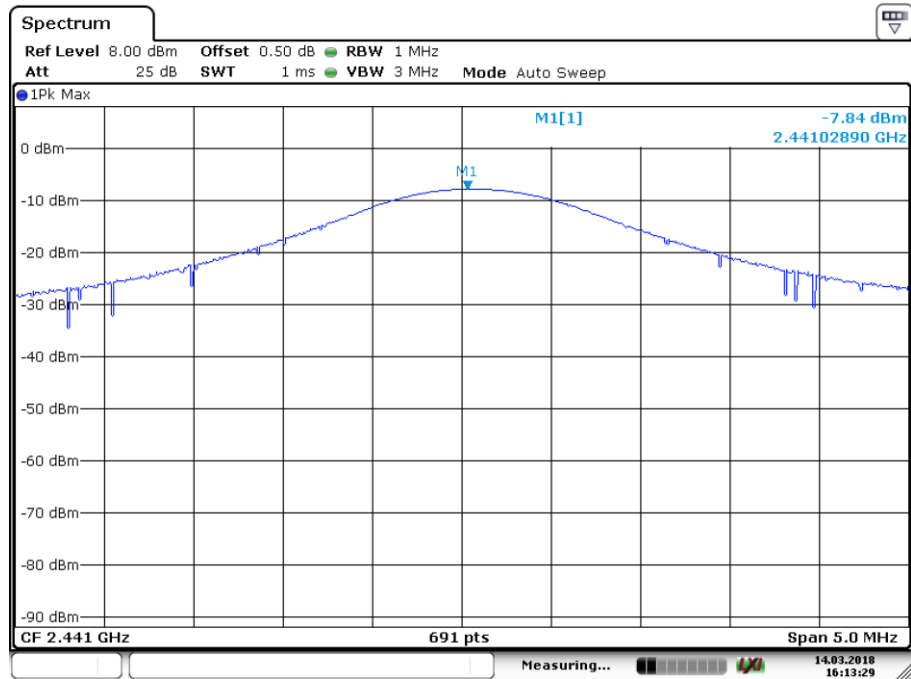
Frequency MHz	Conducted Peak Output Power dBm	Result
Low channel 2402MHz	-8.27	Pass
Middle channel 2441MHz	-7.84	Pass
High channel 2480MHz	-8.76	Pass

Low channel 2402MHz



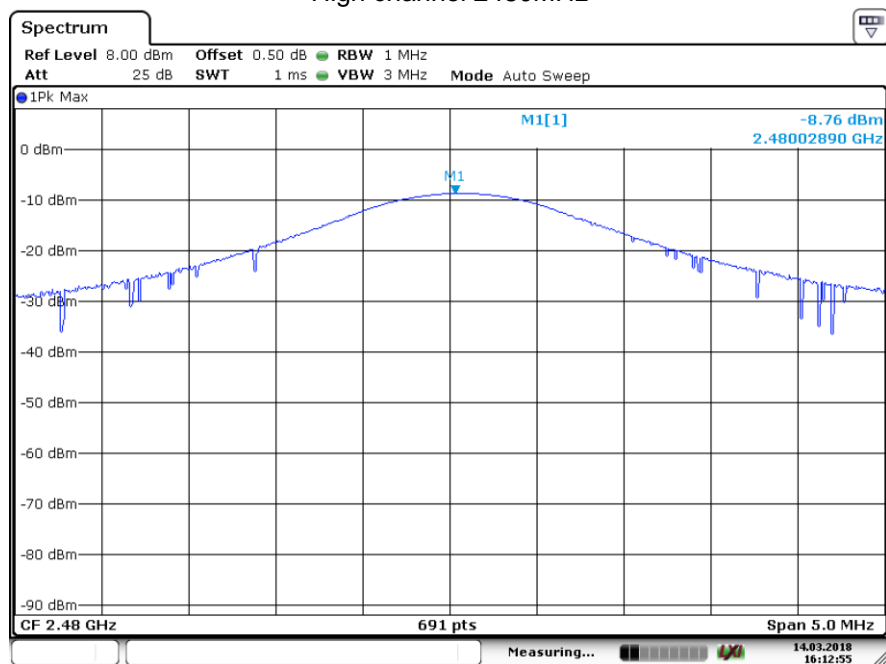
Date: 14.MAR.2018 16:14:03

Middle channel 2441MHz



Date: 14.MAR.2018 16:13:29

High channel 2480MHz



Date: 14.MAR.2018 16:12:55

9.3 20 dB bandwidth and 99% Occupied Bandwidth

Test Method

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
3. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
4. Repeat above procedures until all frequencies measured were complete.

Limit

Limit [kHz]

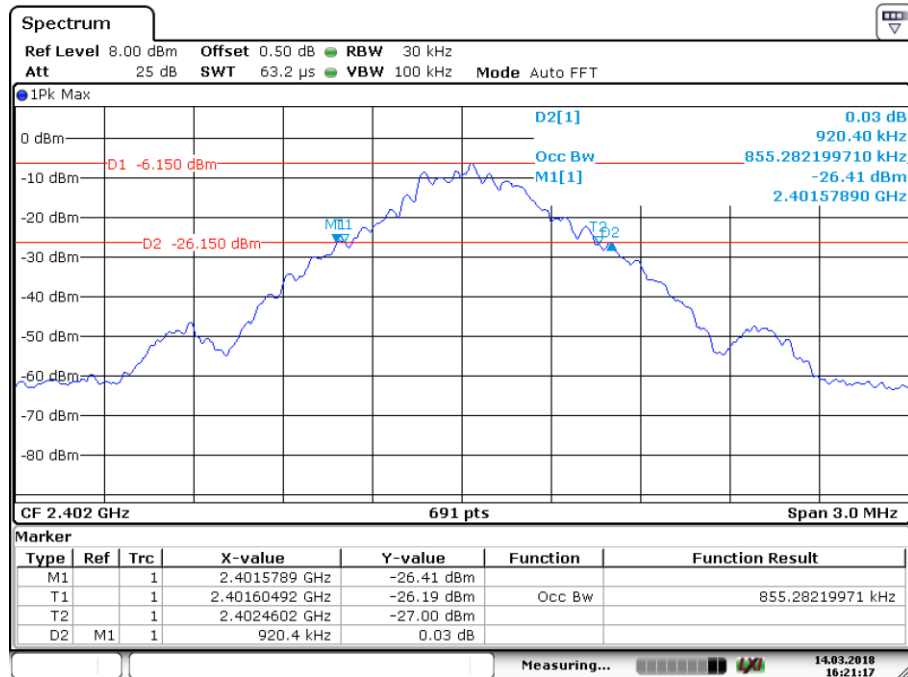
N/A

20 dB bandwidth and 99% Occupied Bandwidth

Bluetooth Mode GFSK Modulation test result

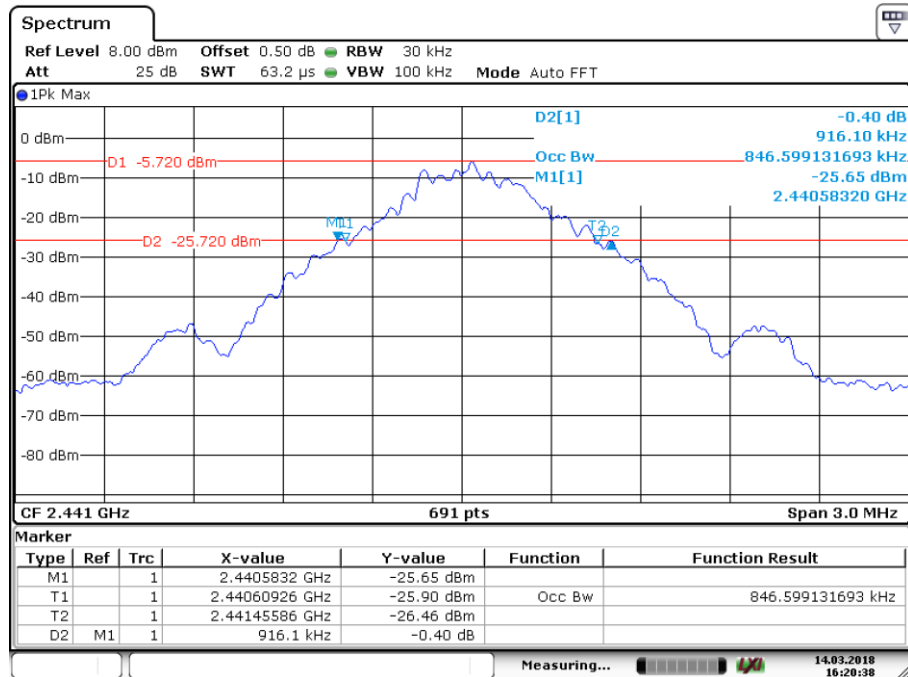
Frequency MHz	20 dB Bandwidth kHz	99% Bandwidth kHz	Limit kHz	Result
2402	920.4	855.28	--	Pass
2441	916.3	846.59	--	Pass
2480	868.3	846.59	--	Pass

Low channel 2402MHz



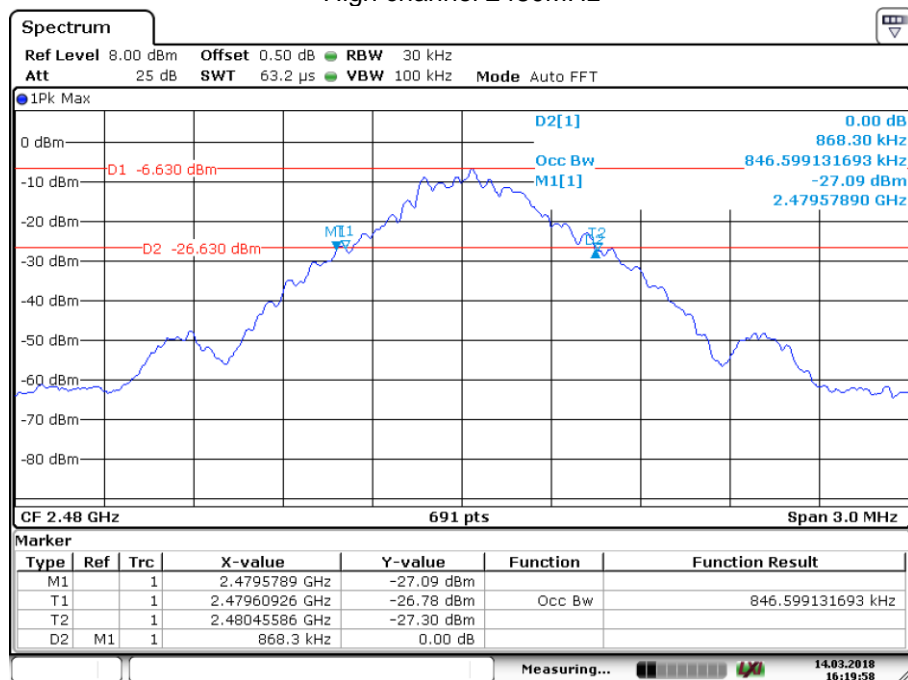
Date: 14.MAR.2018 16:21:17

Middle channel 2441MHz



Date: 14.MAR.2018 16:20:38

High channel 2480MHz



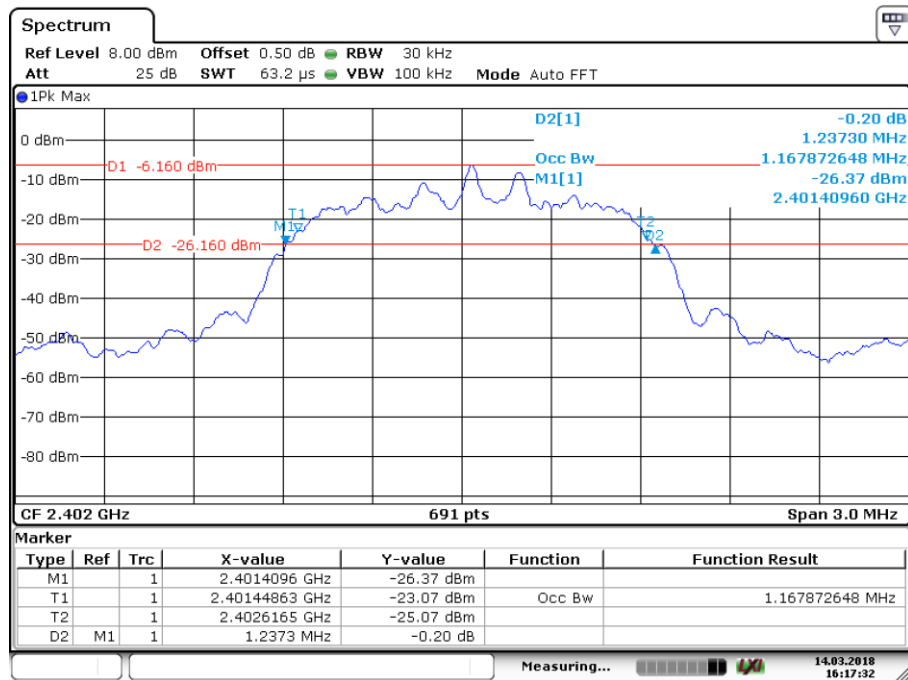
Date: 14.MAR.2018 16:19:58

20 dB bandwidth and 99% Occupied Bandwidth

Bluetooth Mode $\pi/4$ -DQPSK Modulation test result

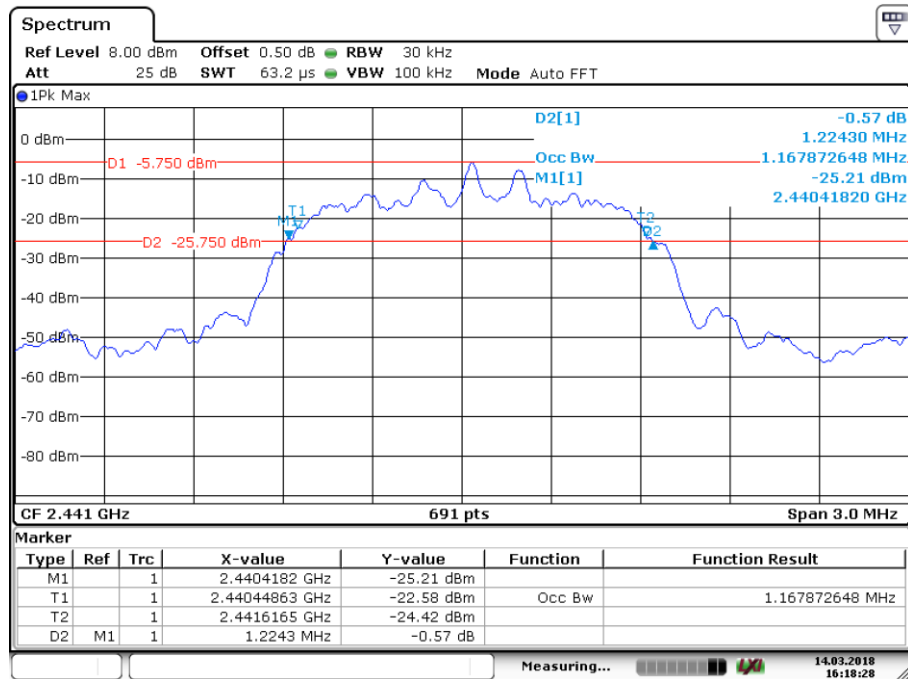
Frequency MHz	20 dB Bandwidth kHz	99% Bandwidth kHz	Limit kHz	Result
2402	1237.3	1167.87	--	Pass
2441	1224.3	1167.87	--	Pass
2480	1228.7	1167.87	--	Pass

Low channel 2402MHz



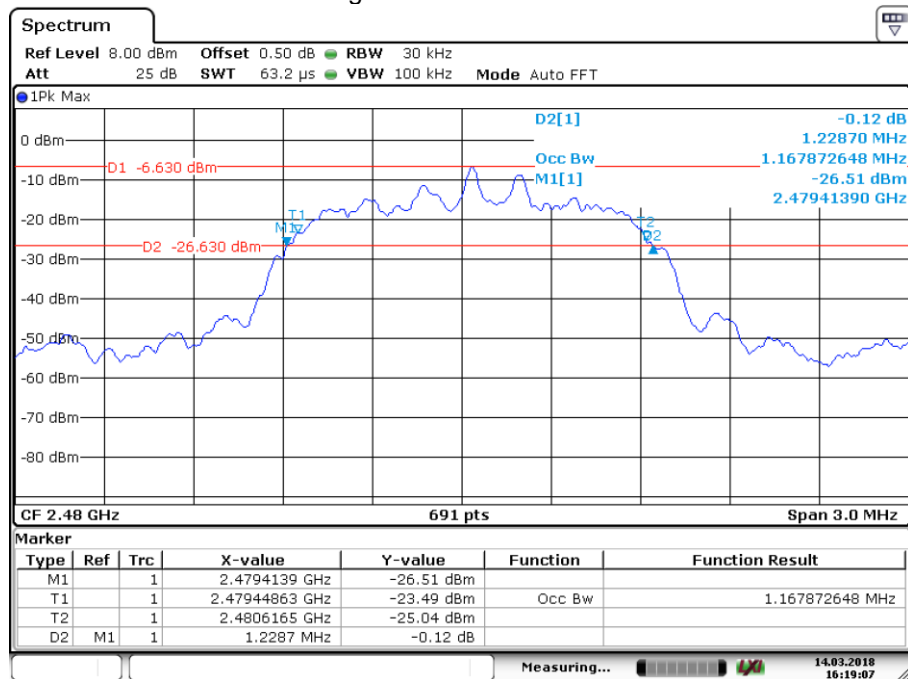
Date: 14.MAR.2018 16:17:31

Middle channel 2441MHz



Date: 14.MAR.2018 16:18:28

High channel 2480MHz



Date: 14.MAR.2018 16:19:07

9.4 Carrier Frequency Separation

Test Method

1. Use the following spectrum analyzer settings:
Span = wide enough to capture the peaks of two adjacent channels, $RBW \geq 1\%$ of the span, $VBW \geq RBW$, Sweep = auto, Detector function = peak
2. By using the Max-Hold function record the separation of two adjacent channels.
3. Measure the frequency difference of these two adjacent channels by spectrum analyzer marker function.
4. Repeat above procedures until all frequencies measured were complete.

Limit

Limit kHz
$\geq 25\text{kHz}$ or $2/3$ of the 20 dB bandwidth which is greater

GFSK Modulation Limit

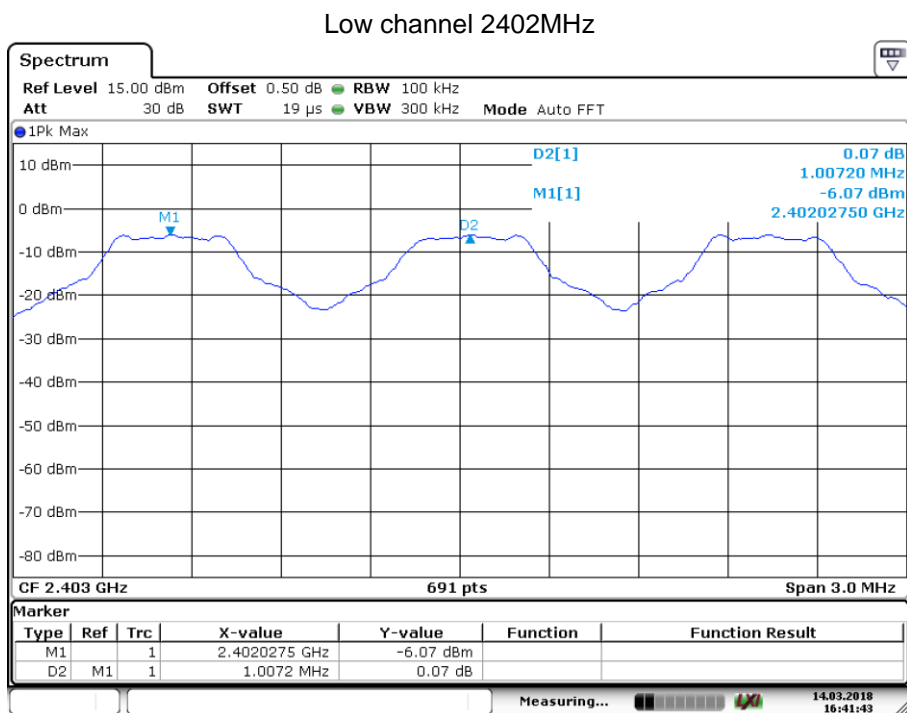
Frequency MHz	2/3 of 20 dB Bandwidth kHz
2402	613.6
2441	610.9
2480	578.9

Carrier Frequency Separation

Test result: The measurement was performed with the typical configuration (normal hopping status), here GFSK modulation mode was used to show compliance.

GFSK Modulation test result

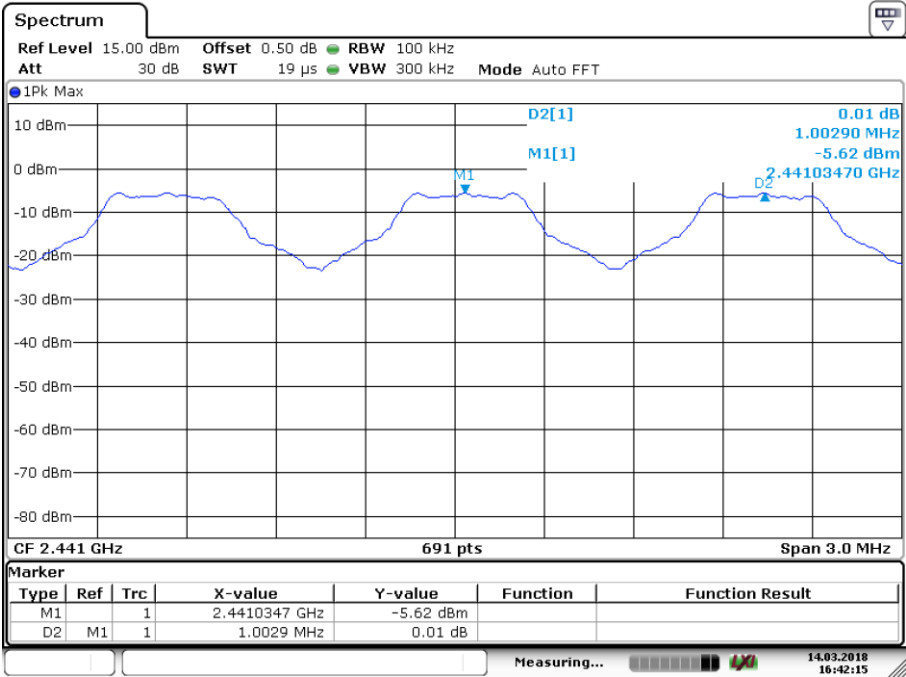
Frequency MHz	Carrier Frequency Separation kHz	Result
2402	1007.2	Pass
2441	1002.9	Pass
2480	994.2	Pass



Date: 14. MAR. 2018 16:41:43

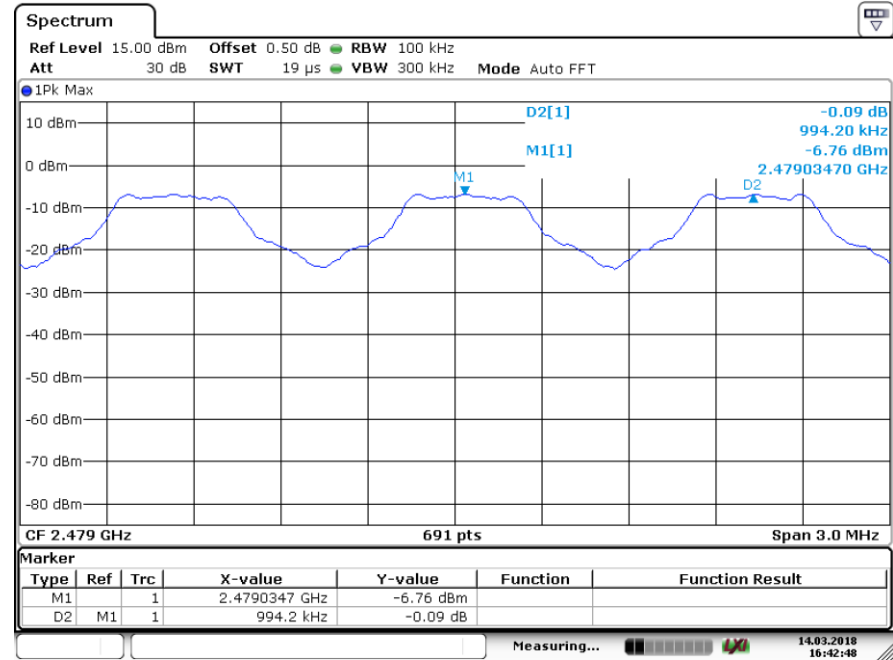


Middle channel 2441MHz



Date: 14.MAR.2018 16:42:15

High channel 2480MHz



Date: 14.MAR.2018 16:42:47

9.5 Number of hopping frequencies

Test Method

1. Use the following spectrum analyzer settings:
Span = wide enough to capture the peaks of two adjacent channels, $RBW \geq 1\%$ of the span, $VBW \geq RBW$, Sweep = auto, Detector function = peak
2. Set the spectrum analyzer on Max-Hold Mode, and then keep the EUT in hopping mode.
3. Record all the signals from each channel until each one has been recorded.
4. Repeat above procedures until all frequencies measured were complete.

Limit

Limit
number

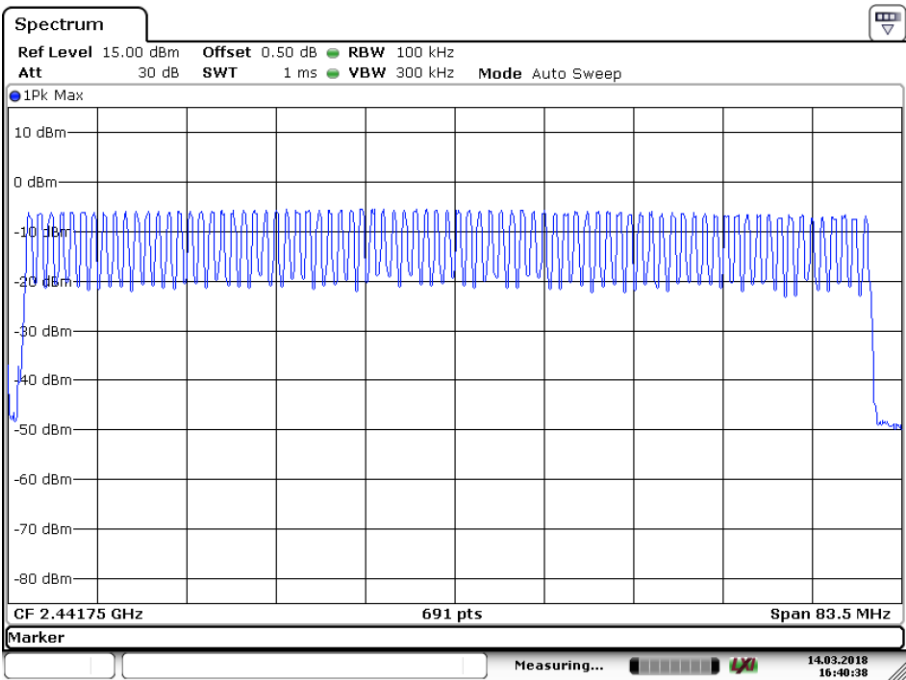
≥ 15



Number of hopping frequencies

Test result: The measurement was performed with the typical configuration (normal hopping status), and the total hopping channels is constant for the all modulation mode according with the Bluetooth Core Specification. Here GFSK modulation mode was used to show compliance.

Number of hopping frequencies	Result
79	Pass



Date: 14.MAR.2018 16:40:37

9.6 Dwell Time

Test Method

1. Connect EUT antenna terminal to the spectrum analyzer with a low loss cable.
Equipment mode: Spectrum analyzer
2. RBW: 1MHz; VBW: 1MHz; SPAN: Zero Span
3. Adjust the center frequency of spectrum analyzer on any frequency be measured.
4. Measure the Dwell Time by spectrum analyzer Marker function.
5. Repeat above procedures until all frequencies measured were complete.

Limit

The average time of occupancy on any frequency shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

Dwell Time

Dwell time

The maximum dwell time shall be 0.4 s.

According to the Bluetooth Core Specification, the worse result (DH5 mode) was reported to show compliance.

The Dwell Time = Burst Width * Total Hops. The detailed calculations are showed as follows:

The duration for dwell time calculation: 0.4 [s] * hopping number = 0.4 [s] * 79 [ch] = 31.6 [s*ch];

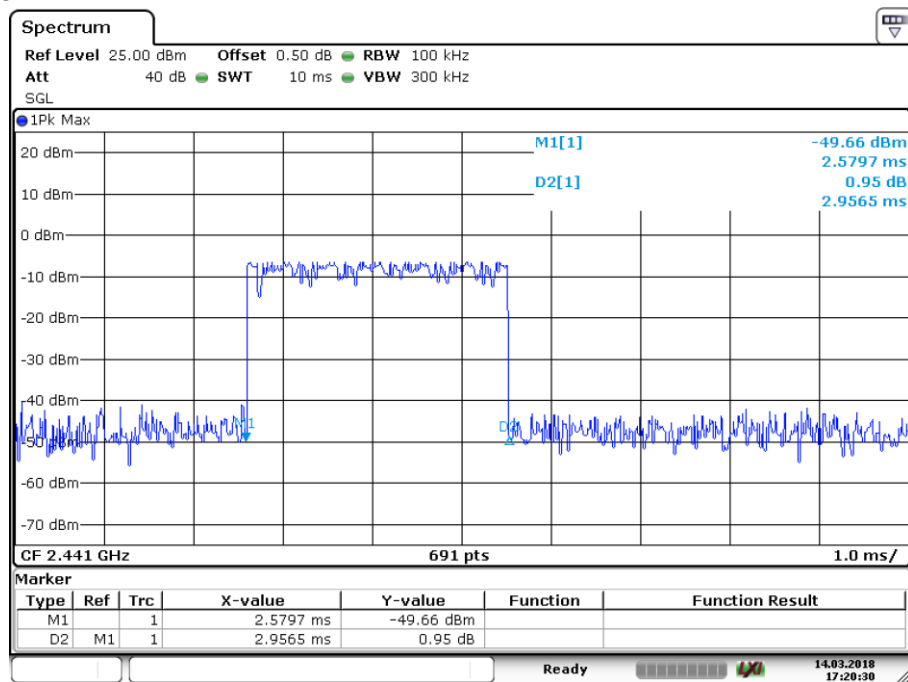
The burst width, which is directly measured, refers to the duration on one channel hop.

The maximum number of hopping channels in 31.6s for DH5=1600 / 6 / 79 *31.6=106.67

Test Result

Modulation	Mode	Reading (us)	Total Hops	Test Result (ms)	Limit (ms)	Result
GFSK	DH5	2579.7	85	219.27	< 400	Pass
$\pi/4$ -DQPSK	2DH5	2971.0	94	279.27	< 400	Pass

GFSK Modulation

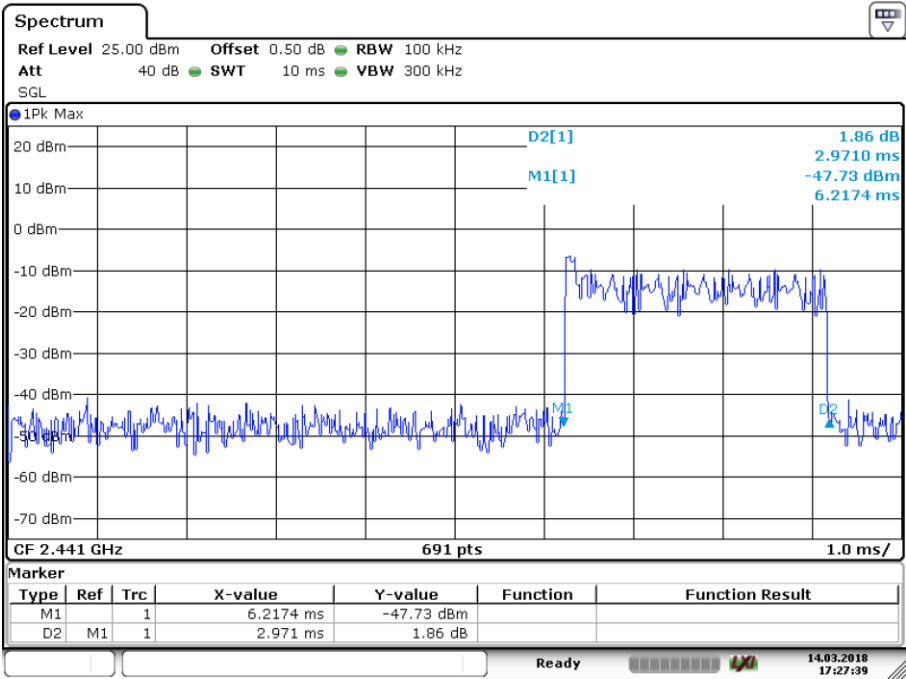


Date: 14.MAR.2018 17:20:30

DH5



$\pi/4$ -DQPSK Modulation



Date: 14.MAR.2018 17:27:38

2DH5

9.7 Spurious RF conducted emissions

Test Method

1. Use the following spectrum analyzer settings:
Span = wide enough to capture the peak level of the in-band emission and all spurious emissions (e.g., harmonics) from the lowest frequency generated in the EUT up through the 10th harmonic. Typically, several plots are required to cover this entire span.
RBW = 100 kHz, VBW ≥ RBW, Sweep = auto, Detector function = peak, Trace = max hold
2. Allow the trace to stabilize. Set the marker on the peak of any spurious emission recorded.
3. The level displayed must comply with the limit specified in this Section. Submit these plots.
4. Repeat above procedures until all frequencies measured were complete.

Limit

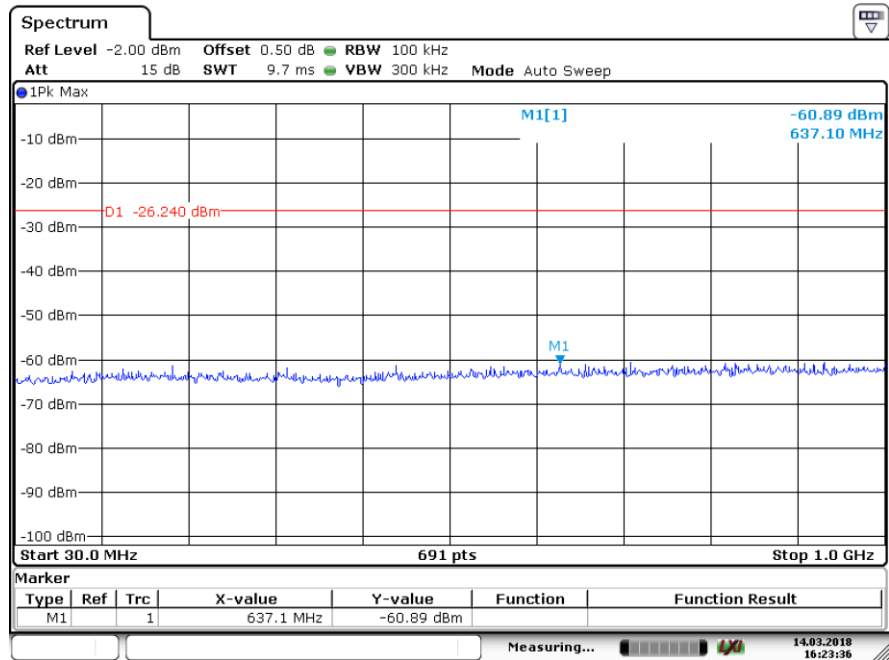
Frequency Range MHz	Limit (dBc)
30-25000	-20

Spurious RF conducted emissions

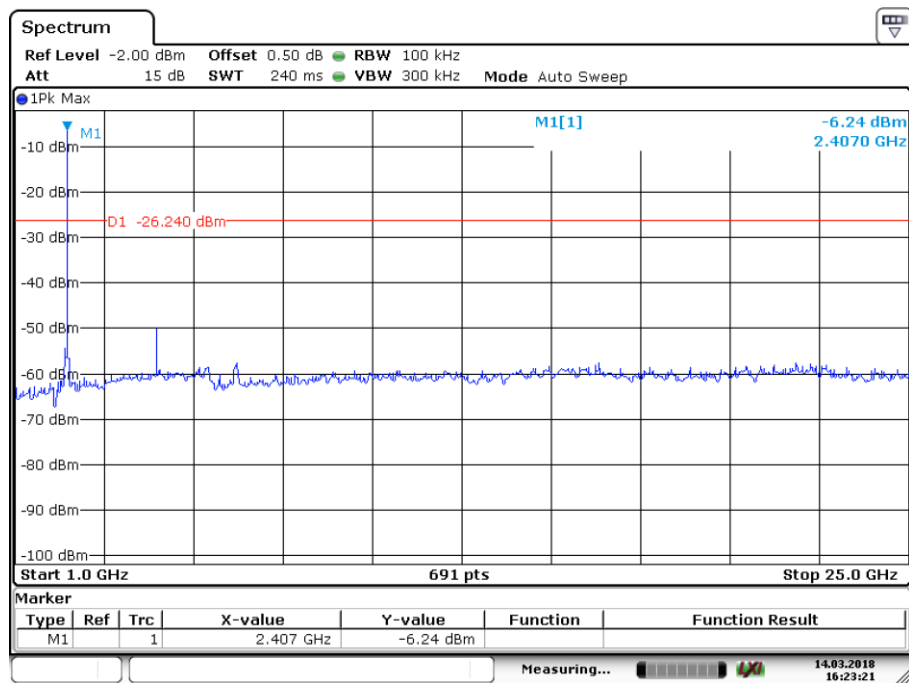
Only the worst case (which is subject to the maximum EIRP, GFSK mode) test result is listed in the report.

BT GFSK Modulation:

Low channel 2402MHz



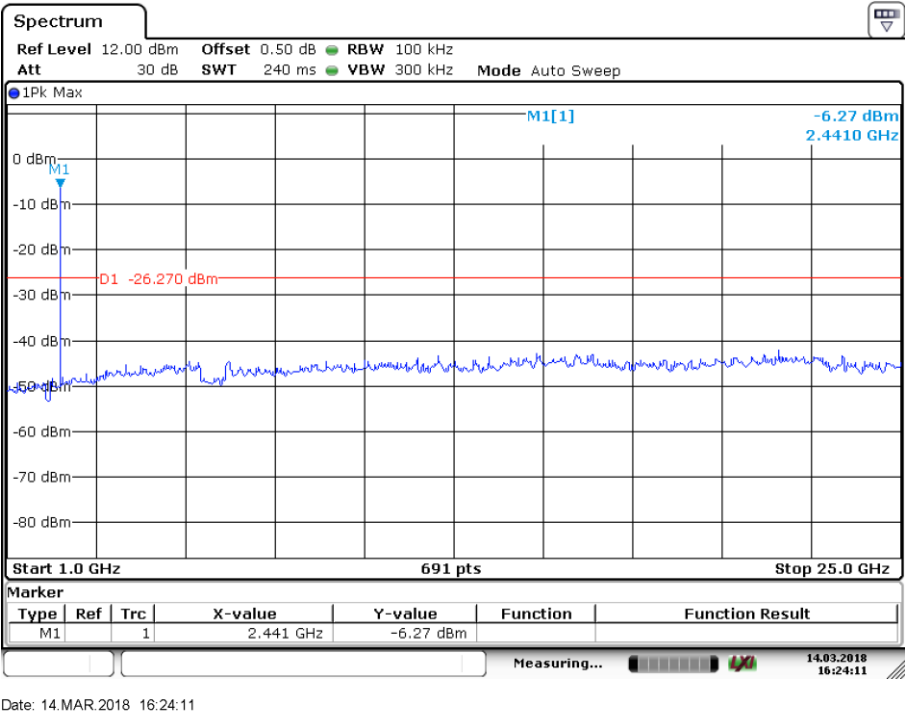
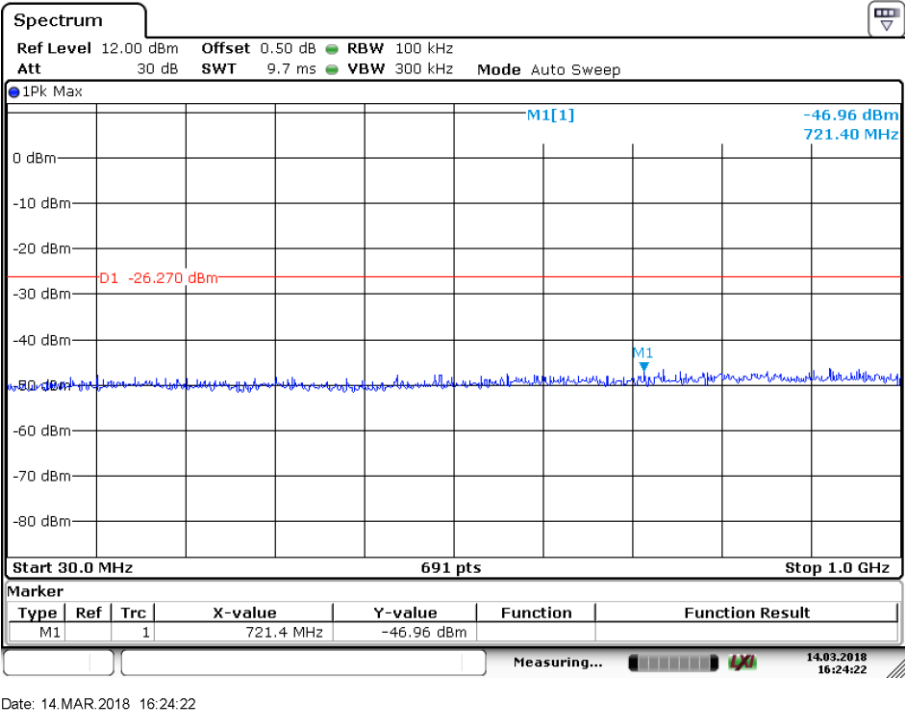
Date: 14.MAR.2018 16:23:36



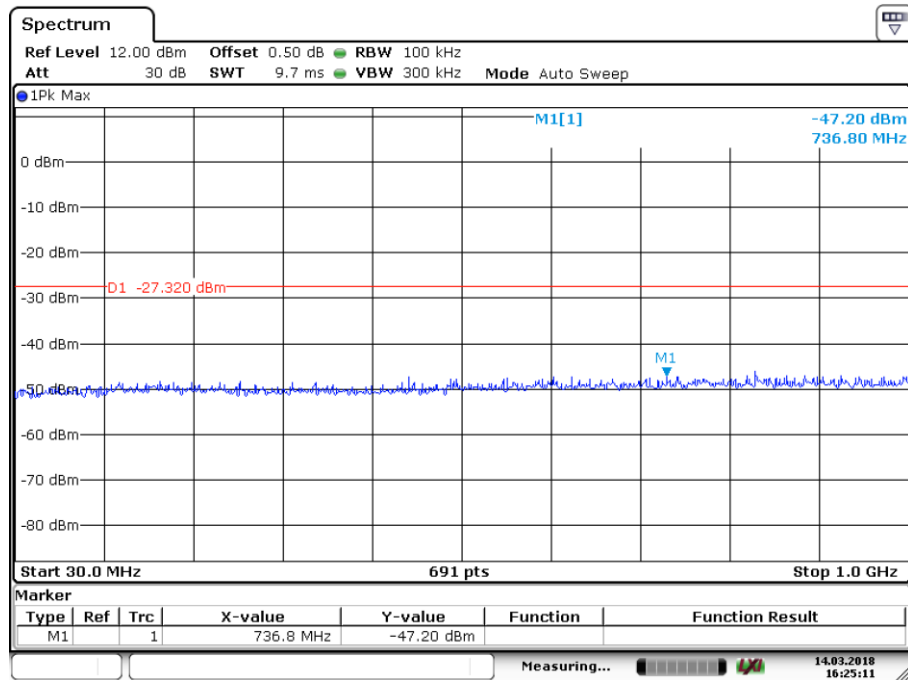
Date: 14.MAR.2018 16:23:22



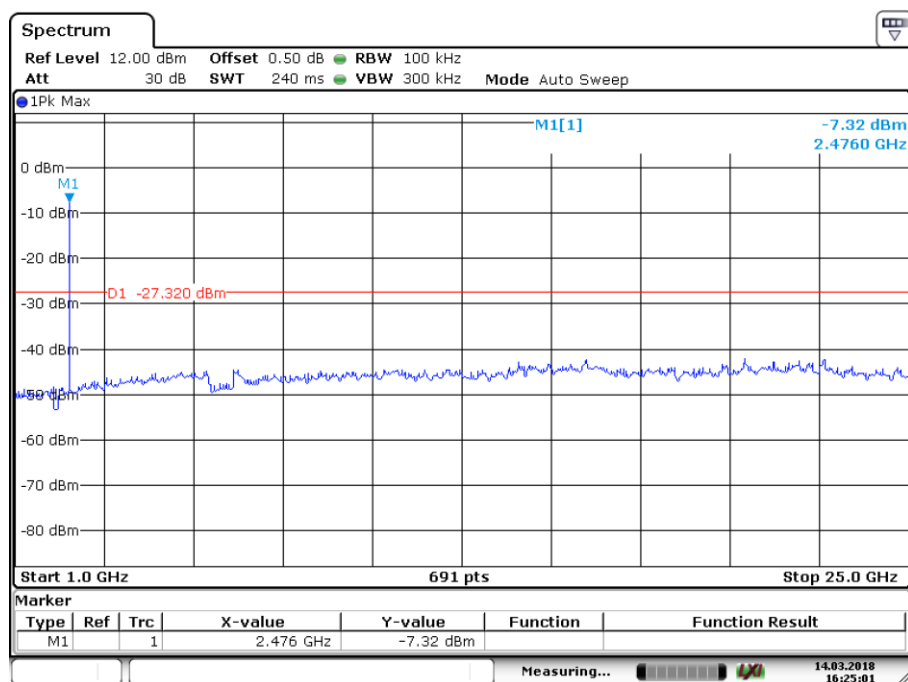
Middle channel 2441MHz



High channel 2480MHz



Date: 14.MAR.2018 16:25:11



Date: 14.MAR.2018 16:25:01

9.8 Band edge testing

Test Method

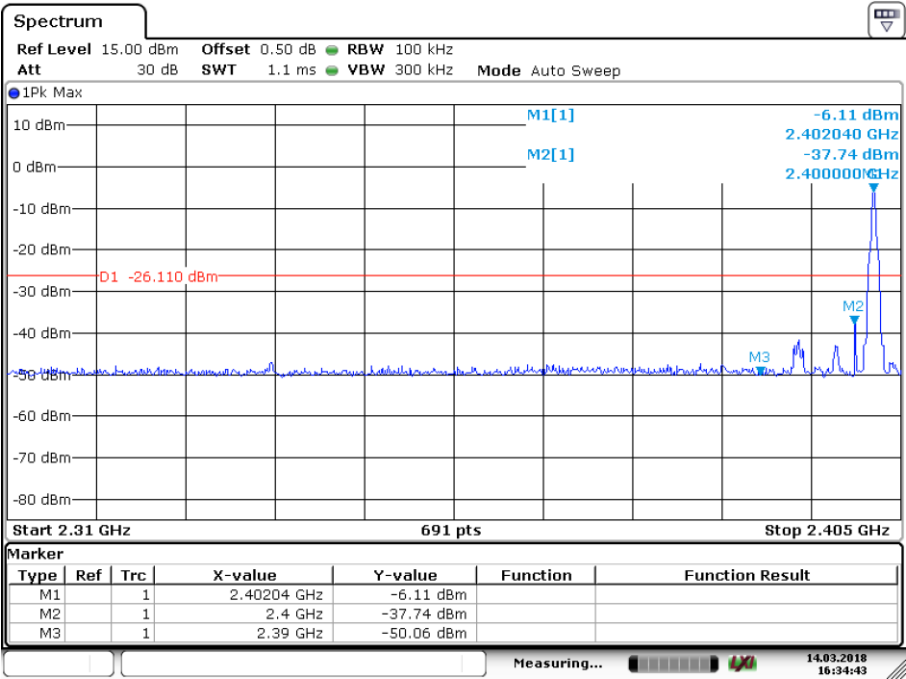
- 1 Use the following spectrum analyzer settings:
Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 100 kHz, VBW \geq RBW, Sweep = auto, Detector function = peak, Trace = max hold
- 2 Allow the trace to stabilize, use the peak and delta measurement to record the result.
- 3 The level displayed must comply with the limit specified in this Section. .
- 4 Repeat the test at the hopping off and hopping on mode, submit all the plots.

Limit:

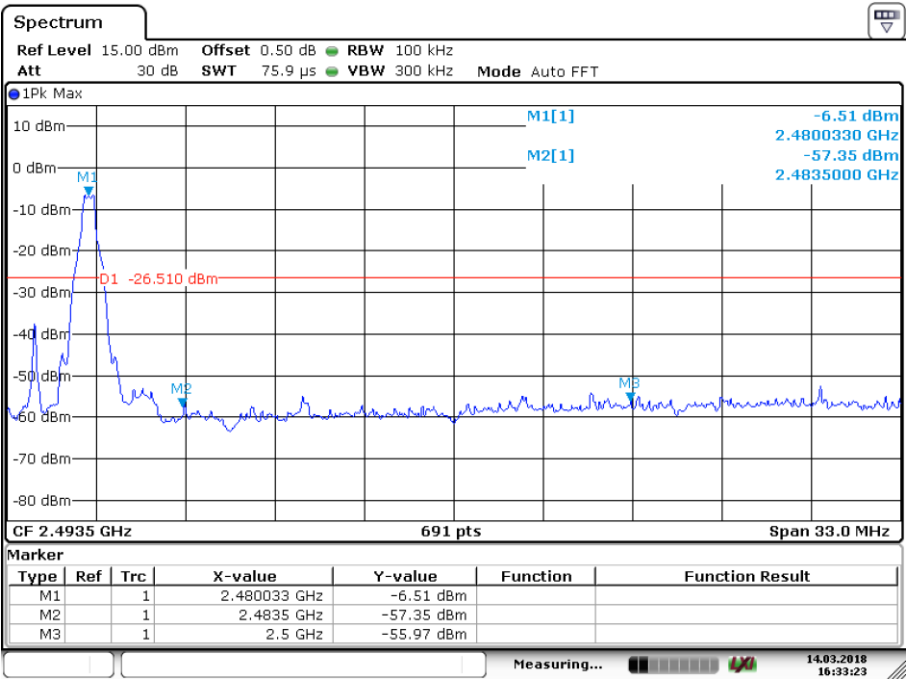
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated device is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided that the transmitter demonstrates compliance with the peak conducted power limits.



GFSK mode:

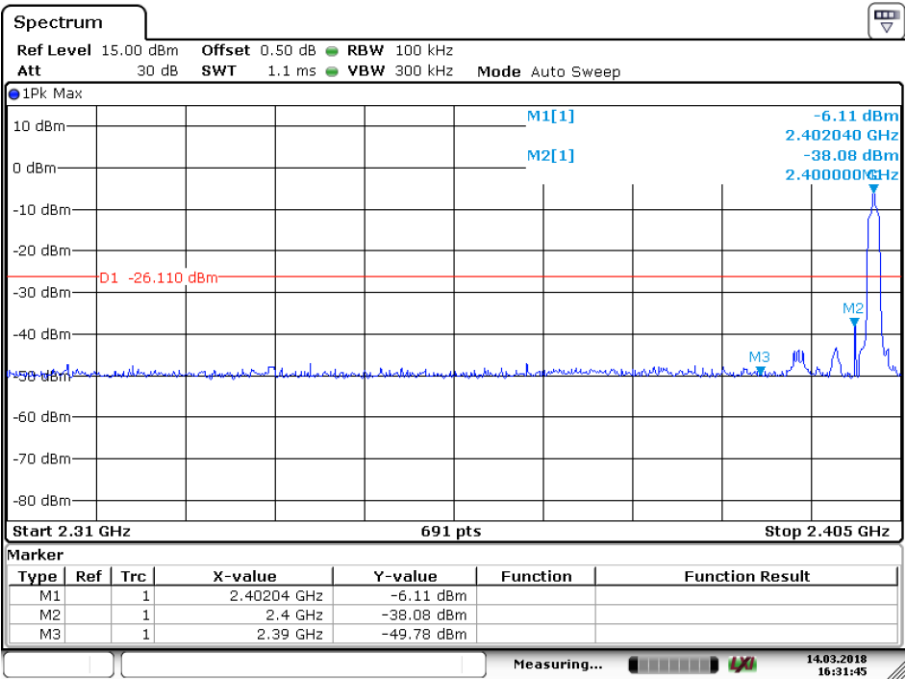


Date: 14.MAR.2018 16:34:43

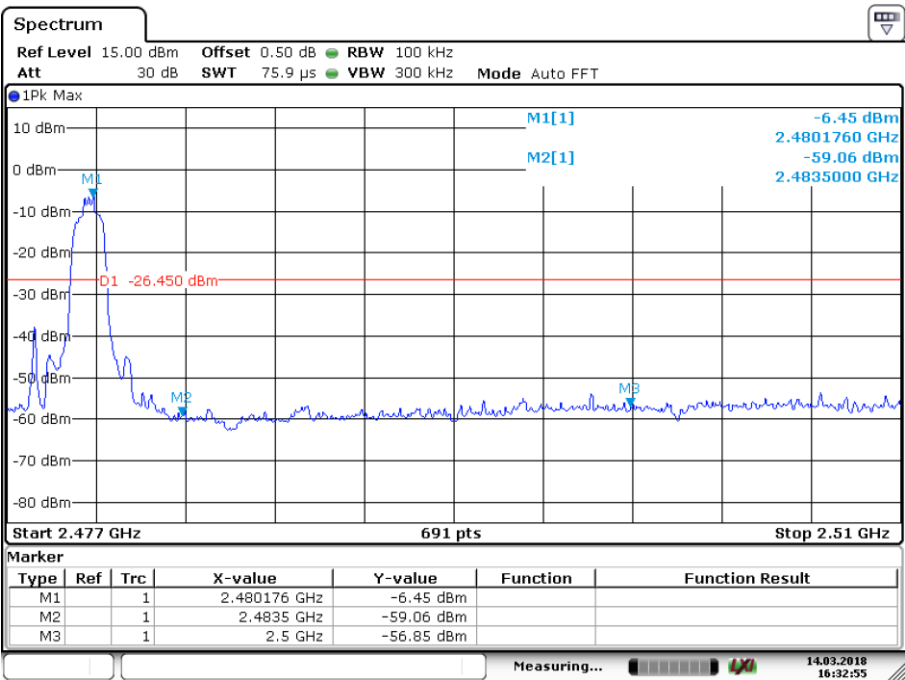


Date: 14.MAR.2018 16:33:23

$\pi/4$ -DQPSK mode:



Date: 14.MAR.2018 16:31:45



Date: 14.MAR.2018 16:32:55

9.9 Spurious radiated emissions for transmitter

Test Method

- 1: The EUT was placed on a turn table which is 1.5m above ground plane for above 1GHz and 0.8m above ground for below 1GHz at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- 2: The EUT was set 3 meters away from the interference – receiving antenna, which was mounted on the top of a variable – height antenna tower.
- 3: The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- 4: For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- 5: Use the following spectrum analyzer settings According to C63.10:

For Above 1GHz

Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 1MHz, VBW \geq RBW for peak measurement and VBW = 10Hz for average measurement, Sweep = auto, Detector function = peak, Trace = max hold.

For Below 1GHz

Use the following spectrum analyzer settings:

Span = wide enough to capture the peak level of the in-band emission and all spurious
RBW = 100 KHz, VBW \geq RBW for peak measurement, Sweep = auto, Detector function = peak, Trace = max hold.

Note:

- 1: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 KHz for Quasi-peak detection (QP) at frequency below 1GHz.
- 2: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 3MHz for peak detection (PK) at frequency above 1GHz.
- 3: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 3MHz for RMS Average ((duty cycle < 98%) for Average detection (AV) at frequency above 1GHz, then the measurement results was added to a correction factor ($20\log(1/\text{duty cycle})$).
- 4: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is 10Hz (duty cycle > 98%) for Average detection (AV) at frequency above 1GHz.

Limit

The radio emission outside the operating frequency band shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power. Radiated emissions which fall in the restricted bands, as defined in section 15.205, must comply with the radiated emission limits specified in section 15.209.

Frequency MHz	Field Strength uV/m	Field Strength dBμV/m	Detector
30-88	100	40	QP
88-216	150	43.5	QP
216-960	200	46	QP
960-1000	500	54	QP
Above 1000	500	54	AV
Above 1000	5000	74	PK

Spurious radiated emissions for transmitter

According to C63.10, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement, so AV emission value did not show in below table if the peak value complies with average limit.

The only worse case (which is subject to the maximum EIRP, GFSK mode) test result is listed in the report.

Transmitting spurious emission test result as below:

GFSK Modulation 2402MHz Test Result

Frequency Band	Frequency MHz	Emission Level dBuV/m	Polarization	Limit dBuV/m	Detector	Corr. dB	Margin dBuV/m	Result
30-1000MHz	849.65	28.10	H	46	QP	--	17.9	Pass
	891.09	28.72	V	46	QP	--	17.3	Pass
1000-25000MHz	2546.18	31.37	H	74	PK	-5.4	42.63	Pass
	4803.75 ^{“*”}	40.84	H	74	PK	2.5	33.16	Pass
	2338.06 ^{“*”}	36.20	V	74	PK	-5.4	37.8	Pass
	12412.03 ^{“*”}	44.44	V	74	PK	12.9	29.56	Pass

GFSK Modulation 2441MHz Test Result

Frequency Band	Frequency MHz	Emission Level dBuV/m	Polarization	Limit dBuV/m	Detector	Corr. dB	Margin dBuV/m	Result
30-1000MHz	--	--	H	43.5	QP	--	--	Pass
	--	--	H	46	QP	--	--	Pass
1000-25000MHz	2377.56 ^{“*”}	39.61	H	74	PK	-5.7	34.39	Pass
	4880.56 ^{“*”}	42.42	H	74	PK	2.5	31.58	Pass
	2561.56	33.39	V	74	PK	-5.4	40.61	Pass
	11329.21 ^{“*”}	43.17	V	74	PK	12.1	30.83	Pass

GFSK Modulation 2480MHz Test Result

Frequency Band	Frequency	Emission Level	Polarization	Limit	Detector	Corr.	Margin	Result
	MHz	dBuV/m		dBμV/m		dB	dBuV/m	
30-1000MHz	--	--	H	43.5	QP	--	--	Pass
	--	--	H	46	QP	--	--	Pass
1000-25000MHz	2544.00	---	H	74	PK	-5.4	36.79	Pass
	2719.87 ^{“*”}	--	H	74	PK	-4.2	26.16	Pass
	4959.84 ^{“*”}	--	V	74	PK	2.7	42.22	Pass
	4959.84 ^{“*”}	--	V	74	PK	2.7	29.96	Pass

Remark:

- (1) “*” means the emission(s) appear within the restrict bands shall follow the requirement of section 15.205.
- (2) Data of measurement within this frequency range shown “--” in the table above means the reading of emissions are the noise floor or attenuated more than 10dB below the permissible limits or the field strength is too small to be measured.
- (3) Above 1GHz: Corrector factor = Antenna Factor + Cable Loss- Amplifier Gain
- (4) Below 1GHz: Corrector factor = Antenna Factor + Cable Loss

10 Test Equipment List

List of Test Instruments

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
Signal Analyzer	Rohde & Schwarz	FSV40	101030	2018-7-7
EMI Test Receiver	Rohde & Schwarz	ESR 26	101269	2018-7-7
Trilog Super Broadband Test Antenna	Schwarzbeck	VULB 9163	707	2018-7-7
Horn Antenna	Rohde & Schwarz	HF907	102294	2018-7-7
Pre-amplifier	Rohde & Schwarz	SCU 18	102230	2018-7-7
3m Semi-anechoic chamber	TDK	9X6X6	----	2019-5-29
EMI Test Receiver	Rohde & Schwarz	ESR 26	101269	2018-7-7
Trilog Super Broadband Test Antenna	Schwarzbeck	VULB 9163	707	2018-7-7
Horn Antenna	Rohde & Schwarz	HF907	102294	2018-7-14
EMI Test Receiver	Rohde & Schwarz	ESR 3	101782	2018-7-14
LISN	Rohde & Schwarz	ENV4200	100249	2018-7-14
LISN	Rohde & Schwarz	ENV216	100326	2018-7-14
ISN	Rohde & Schwarz	ENY81	100177	2018-7-14
ISN	Rohde & Schwarz	ENY81-CA6	101664	2018-7-14
High Voltage Probe	Rohde & Schwarz	TK9420(VT9420)	9420-58	2018-7-14
RF Current Probe	Rohde & Schwarz	EZ-17	100816	2018-7-14

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
Signal Generator	Rohde & Schwarz	SMB100A	108272	2018-7-7
Signal Analyzer	Rohde & Schwarz	FSV40	101030	2018-7-7
Vector Signal Generator	Rohde & Schwarz	SMU 200A	105324	2018-7-7
RF Switch Module	Rohde & Schwarz	OSP120/OSP-B157	101226/100851	2018-7-7
Power Splitter	Weinschel	1580	SC319	2018-7-7
10dB Attenuator	Weinschel	56-10	58764	2018-7-14
10dB Attenuator	R&S	DNF	DNF-001	2018-7-14
10dB Attenuator	R&S	DNF	DNF-002	2018-7-14
10dB Attenuator	R&S	DNF	DNF-003	2018-7-14
10dB Attenuator	R&S	DNF	DNF-004	2018-7-14
Test software	Rohde & Schwarz	EMC32	Version 9.26.01	N/A

DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	CAL. DUE DATE
EMI Test Receiver	Rohde & Schwarz	ESR 3	101782	2018-7-14
LISN	Rohde & Schwarz	ENV4200	100249	2018-7-14
LISN	Rohde & Schwarz	ENV432	101318	2018-7-14
LISN	Rohde & Schwarz	ENV216	100326	2018-7-14
ISN	Rohde & Schwarz	ENY81	100177	2018-7-14
ISN	Rohde & Schwarz	ENY81-CA6	101664	2018-7-14
High Voltage Probe	Rohde & Schwarz	TK9420(VT9420)	9420-584	2018-7-14
RF Current Probe	Rohde & Schwarz	EZ-17	100816	2018-7-14
Attenuator	Shanghai Huaxiang	TS2-26-3	080928189	2018-7-7
Test software	Rohde & Schwarz	EMC32	Version9.15.00	N/A

C - Conducted RF tests

- Conducted peak output power
- 6dB bandwidth and 99% Occupied Bandwidth
- Power spectral density*
- Spurious RF conducted emissions
- Band edge

11 System Measurement Uncertainty

For a 95% confidence level, the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 were:

System Measurement Uncertainty	
Test Items	Extended Uncertainty
Uncertainty for Radiated Emission in 3m chamber 30MHz-1000MHz	Horizontal: 4.99dB; Vertical: 4.97dB;
Uncertainty for Radiated Emission in 3m chamber 1000MHz-18000MHz	Horizontal: 4.96dB; Vertical: 4.95dB;
Uncertainty for Conducted Emission 150kHz-30MHz (for test using AMN ENV216 or ENV4200)	3.46dB
Uncertainty for Conducted RF test with TS 8997	Power level test involved: 2.06dB Frequency test involved: 1.16×10^{-7}